

## N-channel 600 V, 0.290 $\Omega$ typ., 8 A MDmesh™ M2 Power MOSFET in a PowerFLAT™ 5x6 HV package

Datasheet - production data

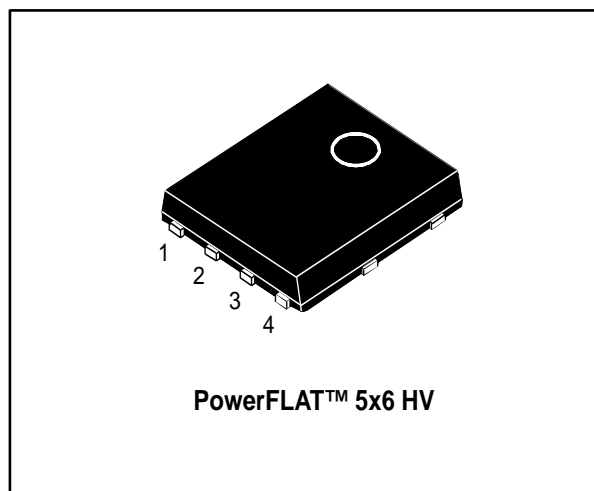
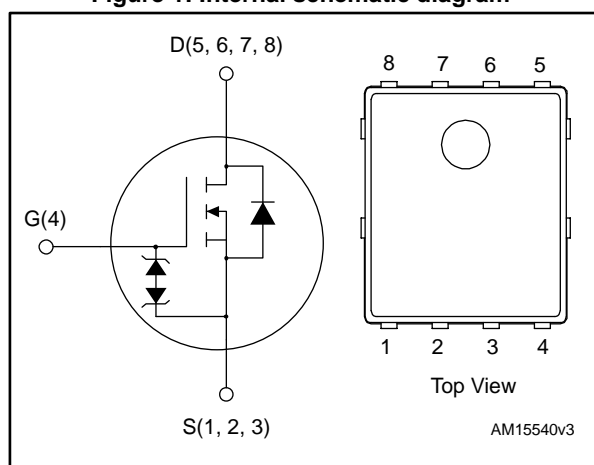


Figure 1: Internal schematic diagram



### Features

| Order code | V <sub>DS</sub> @ T <sub>Jmax</sub> | R <sub>DS(on)</sub> max. | I <sub>D</sub> |
|------------|-------------------------------------|--------------------------|----------------|
| STL16N60M2 | 650 V                               | 0.355 $\Omega$           | 8 A            |

- Extremely low gate charge
- Excellent output capacitance (C<sub>oss</sub>) profile
- 100% avalanche tested
- Zener-protected

### Applications

- Switching applications

### Description

This device is an N-channel Power MOSFET developed using MDmesh™ M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

Table 1: Device summary

| Order code | Marking | Package           | Packing       |
|------------|---------|-------------------|---------------|
| STL16N60M2 | 16N60M2 | PowerFLAT™ 5x6 HV | Tape and reel |

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# 1 Electrical ratings

**Table 2: Absolute maximum ratings**

| Symbol                  | Parameter   | Value            | Unit |
|-------------------------|---|------------------|------|
| $V_{GS}$                | Gate-source voltage   | $\pm 25$         | V    |
| $I_D$                   | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$  | 8 <sup>(1)</sup> | A    |
| $I_D$                   | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$ | 5                | A    |
| $I_{DM}$ <sup>(2)</sup> | Drain current (pulsed)  | 32               | A    |
| $P_{TOT}$               | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$           | 52               | W    |
| $dv/dt$ <sup>(3)</sup>  | Peak diode recovery voltage slope                               | 15               | V/ns |
| $dv/dt$ <sup>(4)</sup>  | MOSFET $dv/dt$ ruggedness                                       | 50               | V/ns |
| $T_{stg}$               | Storage temperature   | - 55 to 150      | °C   |
| $T_j$                   | Max. operating junction temperature                             | 150              |      |

**Notes:**

<sup>(1)</sup>The value is limited by package.

<sup>(2)</sup>Pulse width limited by safe operating area.

<sup>(3)</sup> $I_{SD} \leq 8\text{ A}$ ,  $di/dt \leq 400\text{ A}/\mu\text{s}$ ;  $V_{DS\text{ peak}} < V_{(BR)DSS}$ ,  $V_{DD} = 80\% V_{(BR)DSS}$

<sup>(4)</sup> $V_{DS} \leq 480\text{ V}$

**Table 3: Thermal data**

| Symbol         | Parameter  | Value | Unit |
|----------------|--|-------|------|
| $R_{thj-case}$ | Thermal resistance junction-case max               | 2.40  | °C/W |
| $R_{thj-pcb}$  | Thermal resistance junction-pcb max <sup>(1)</sup> | 59    | °C/W |

**Notes:**

<sup>(1)</sup>When mounted on 1 inch<sup>2</sup> FR-4, 2 Oz copper board

**Table 4: Avalanche characteristics**

| Symbol   | Parameter  | Value | Unit |
|----------|--|-------|------|
| $I_{AR}$ | Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )                                 | 2     | A    |
| $E_{AS}$ | Single pulse avalanche energy (starting $T_j = 25\text{ }^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{ V}$ ) | 130   | mJ   |

## 2 Electrical characteristics

( $T_C = 25\text{ °C}$  unless otherwise specified)

**Table 5: On/off states**

| Symbol        | Parameter                         | Test conditions  | Min. | Typ.  | Max.     | Unit          |
|---------------|-----------------------------------|--|------|-------|----------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage    | $V_{GS} = 0\text{ V}$ , $I_D = 1\text{ mA}$                                | 600  |       |          | V             |
| $I_{DSS}$     | Zero gate voltage Drain current   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 600\text{ V}$                            |      |       | 1        | $\mu\text{A}$ |
|               |                                   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 600\text{ V}$ ,<br>$T_C = 125\text{ °C}$ |      |       | 100      | $\mu\text{A}$ |
| $I_{GSS}$     | Gate-body leakage current         | $V_{DS} = 0\text{ V}$ , $V_{GS} = \pm 25\text{ V}$                         |      |       | $\pm 10$ | $\mu\text{A}$ |
| $V_{GS(th)}$  | Gate threshold voltage            | $V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$                         | 2    | 3     | 4        | V             |
| $R_{DS(on)}$  | Static drain-source on-resistance | $V_{GS} = 10\text{ V}$ , $I_D = 4\text{ A}$                                |      | 0.290 | 0.355    | $\Omega$      |

**Table 6: Dynamic**

| Symbol                     | Parameter                     | Test conditions  | Min. | Typ. | Max. | Unit     |
|----------------------------|-------------------------------|--|------|------|------|----------|
| $C_{iss}$                  | Input capacitance             | $V_{DS} = 100\text{ V}$ , $f = 1\text{ MHz}$ ,<br>$V_{GS} = 0\text{ V}$  | -    | 704  | -    | pF       |
| $C_{oss}$                  | Output capacitance            |  | -    | 38   | -    | pF       |
| $C_{rss}$                  | Reverse transfer capacitance  |  | -    | 1.2  | -    | pF       |
| $C_{oss\text{ eq.}}^{(1)}$ | Equivalent output capacitance | $V_{DS} = 0\text{ V}$ to $480\text{ V}$ ,<br>$V_{GS} = 0\text{ V}$   | -    | 140  | -    | pF       |
| $R_G$                      | Intrinsic gate resistance     | $f = 1\text{ MHz}$ open drain  | -    | 5.3  | -    | $\Omega$ |
| $Q_g$                      | Total gate charge             | $V_{DD} = 480\text{ V}$ , $I_D = 12\text{ A}$ ,<br>$V_{GS} = 10\text{ V}$ (see <a href="#">Figure 15: "Gate charge test circuit"</a> ) | -    | 19   | -    | nC       |
| $Q_{gs}$                   | Gate-source charge            |  | -    | 3.3  | -    | nC       |
| $Q_{gd}$                   | Gate-drain charge             |  | -    | 9.5  | -    | nC       |

**Notes:**

<sup>(1)</sup> $C_{oss\text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 7: Switching times**

| Symbol       | Parameter           | Test conditions   | Min. | Typ. | Max. | Unit |
|--------------|---------------------|---|------|------|------|------|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD} = 300\text{ V}$ , $I_D = 6\text{ A}$<br>$R_G = 4.7\text{ }\Omega$ , $V_{GS} = 10\text{ V}$ (see <a href="#">Figure 14: "Switching times test circuit for resistive load"</a> and <a href="#">Figure 19: "Switching time waveform"</a> ) | -    | 10.5 | -    | ns   |
| $t_r$        | Rise time           |   | -    | 9.5  | -    | ns   |
| $t_{d(off)}$ | Turn-off-delay time |   | -    | 58   | -    | ns   |
| $t_f$        | Fall time           |   | -    | 18.5 | -    | ns   |

Table 8: Source drain diode

| Symbol          | Parameter                     | Test conditions   | Min. | Typ. | Max. | Unit          |
|-----------------|-------------------------------|---|------|------|------|---------------|
| $I_{SD}$        | Source-drain current          |   | -    |      | 8    | A             |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |   | -    |      | 32   | A             |
| $V_{SD}^{(2)}$  | Forward on voltage            | $V_{GS} = 0\text{ V}, I_{SD} = 8\text{ A}$  | -    |      | 1.6  | V             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 12\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, V_{DD} = 60\text{ V}$<br>(see <a href="#">Figure 16: "Test circuit for inductive load switching and diode recovery times"</a> )                                  | -    | 316  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 3.25 |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 20.5 |      | A             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 12\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, V_{DD} = 60\text{ V}, T_j = 150\text{ }^\circ\text{C}$<br>(see <a href="#">Figure 16: "Test circuit for inductive load switching and diode recovery times"</a> ) | -    | 455  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 4.8  |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 21   |      | A             |

**Notes:**

<sup>(1)</sup>Pulse width is limited by safe operating area

<sup>(2)</sup>Pulse test: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

Table 9: Gate-source Zener diode

| Symbol        | Parameter                     | Test conditions                              | Min. | Typ. | Max. | Unit |
|---------------|-------------------------------|--|------|------|------|------|
| $V_{(BR)GSO}$ | Gate-source breakdown voltage | $I_{GS} = \pm 1\text{ mA}, I_D = 0\text{ A}$ | 30   | -    | -    | V    |

## 2.1 Electrical characteristics (curves)

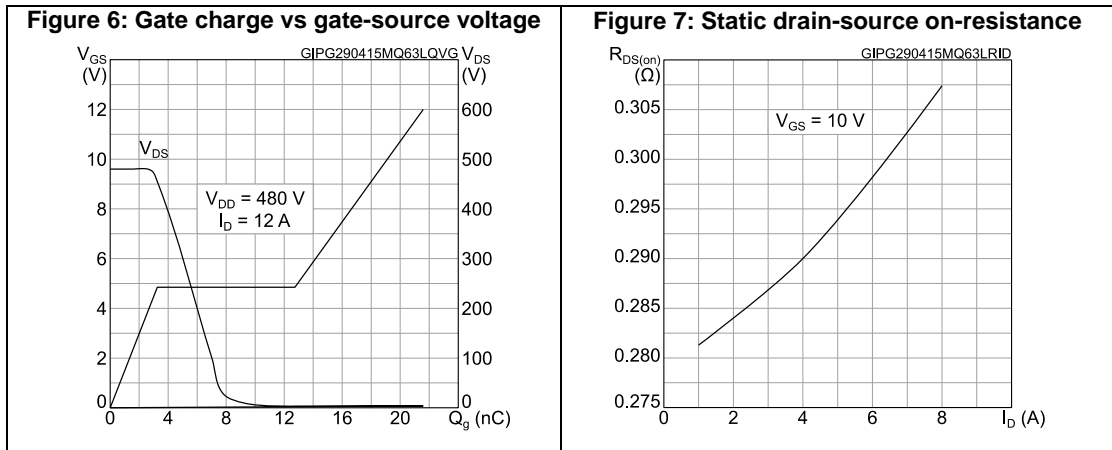
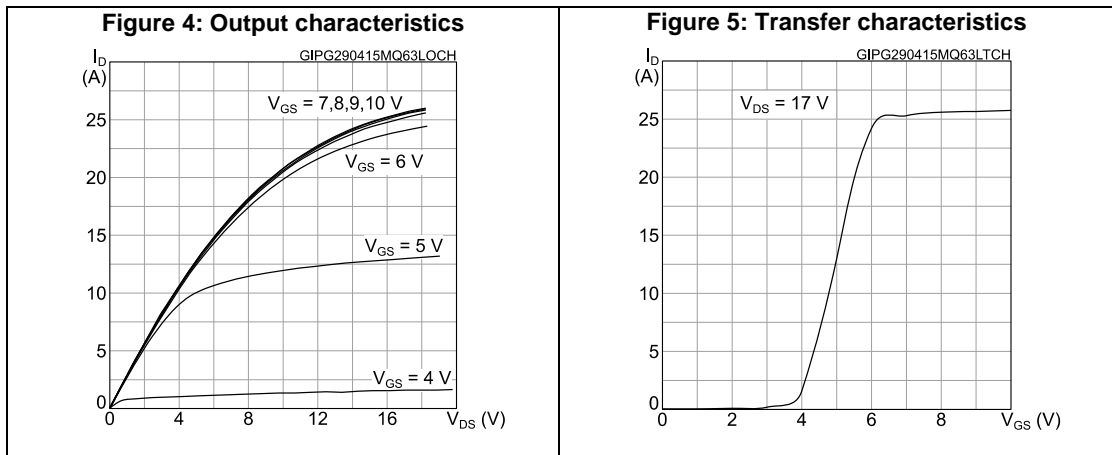
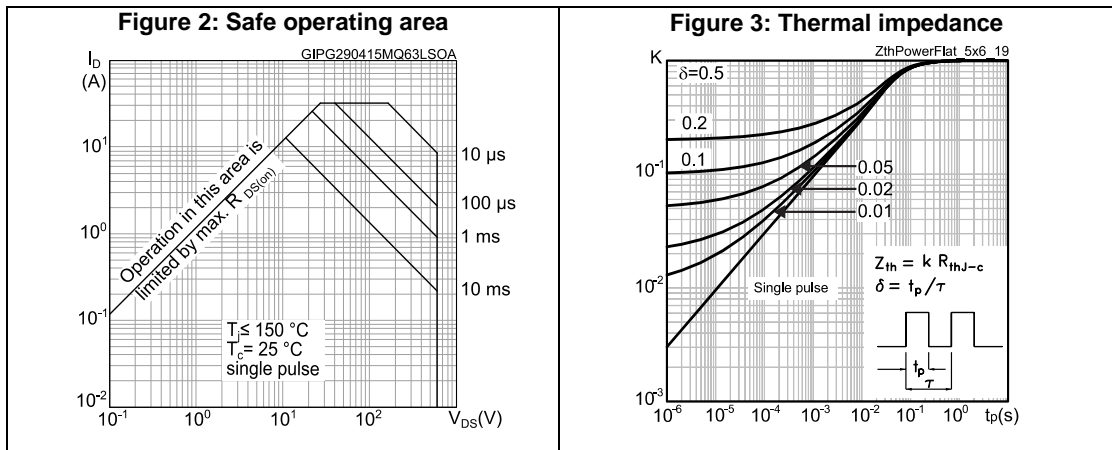


Figure 8: Capacitance variations

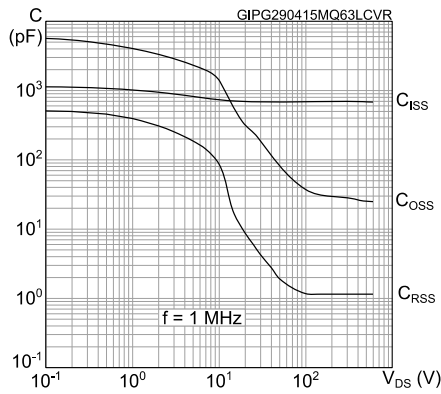


Figure 9: Normalized gate threshold voltage vs temperature

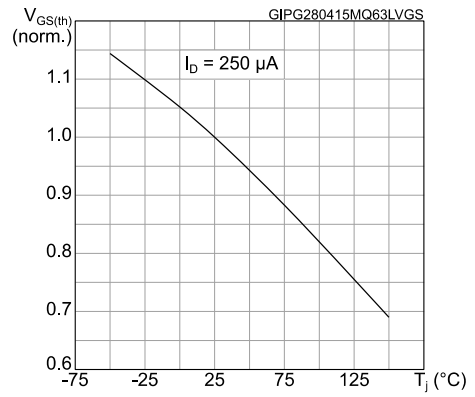


Figure 10: Normalized on-resistance vs temperature

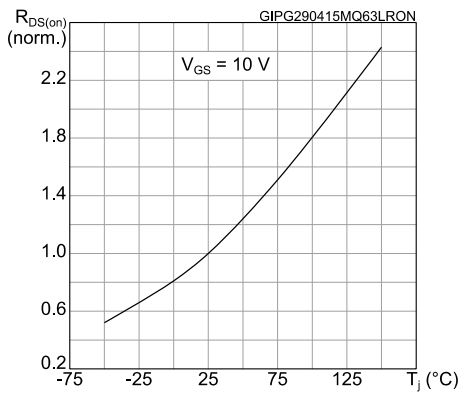


Figure 11: Normalized V(BR)DSS vs temperature

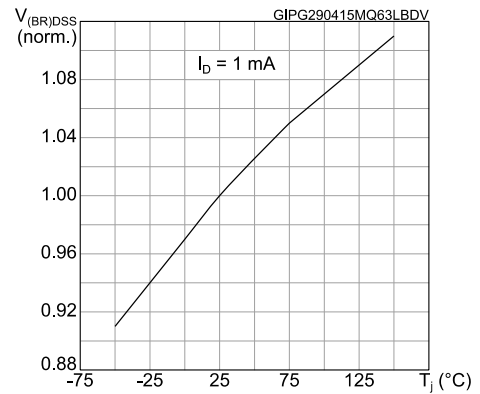


Figure 12: Source-drain diode forward characteristics

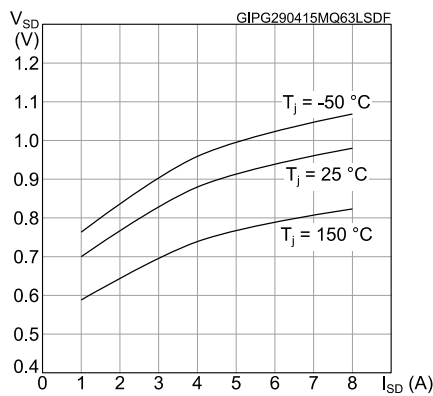
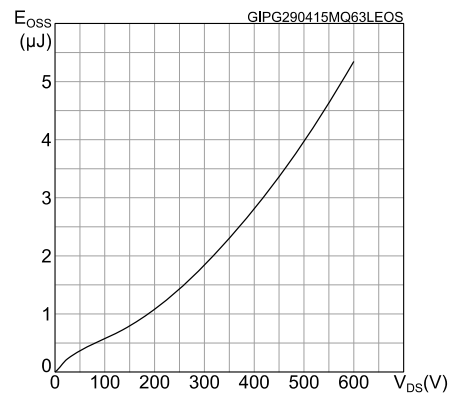
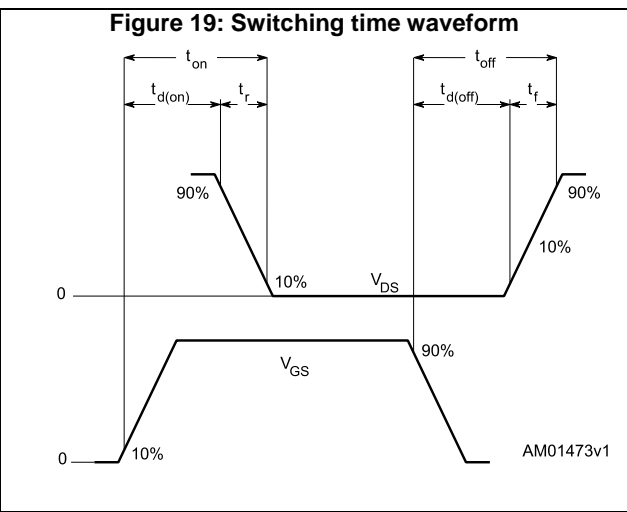
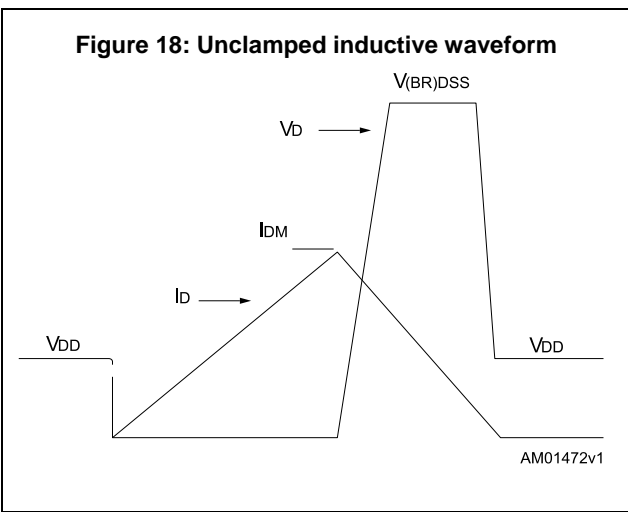
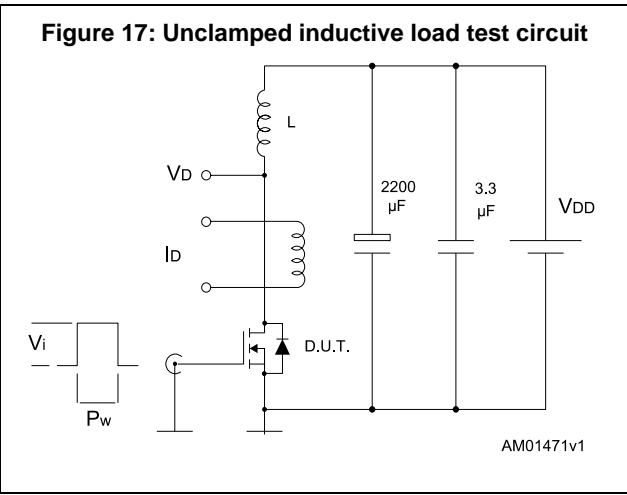
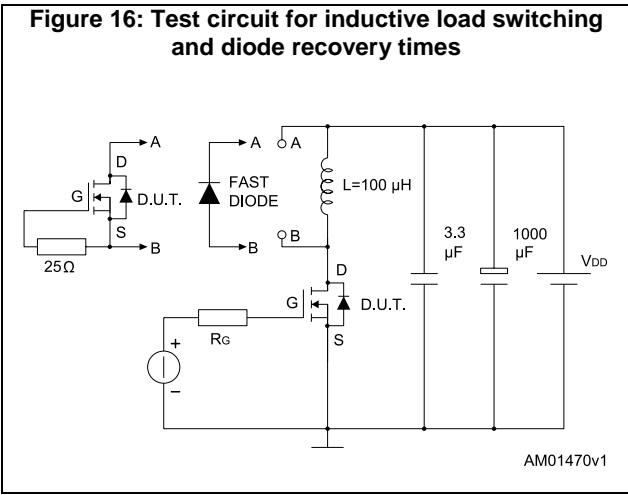
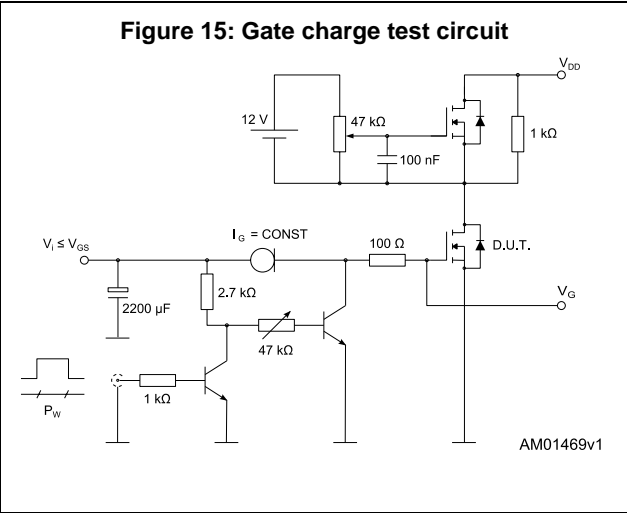
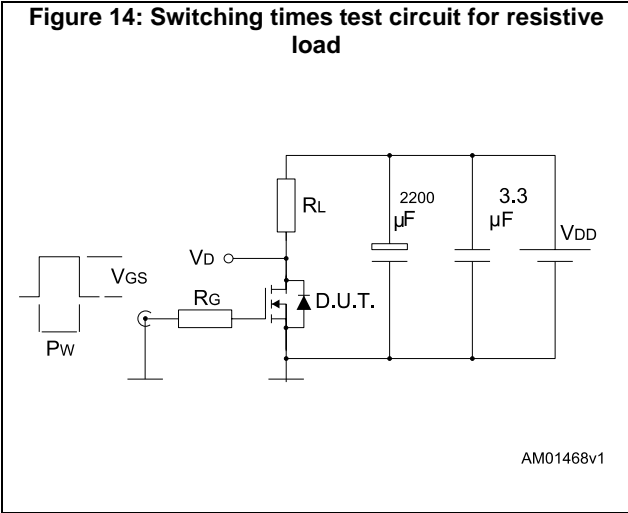


Figure 13: Output capacitance stored energy



### 3 Test circuits





## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

### 4.1 PowerFLAT™ 5x6 HV package information

Figure 20: PowerFLAT™ 5x6 HV package outline

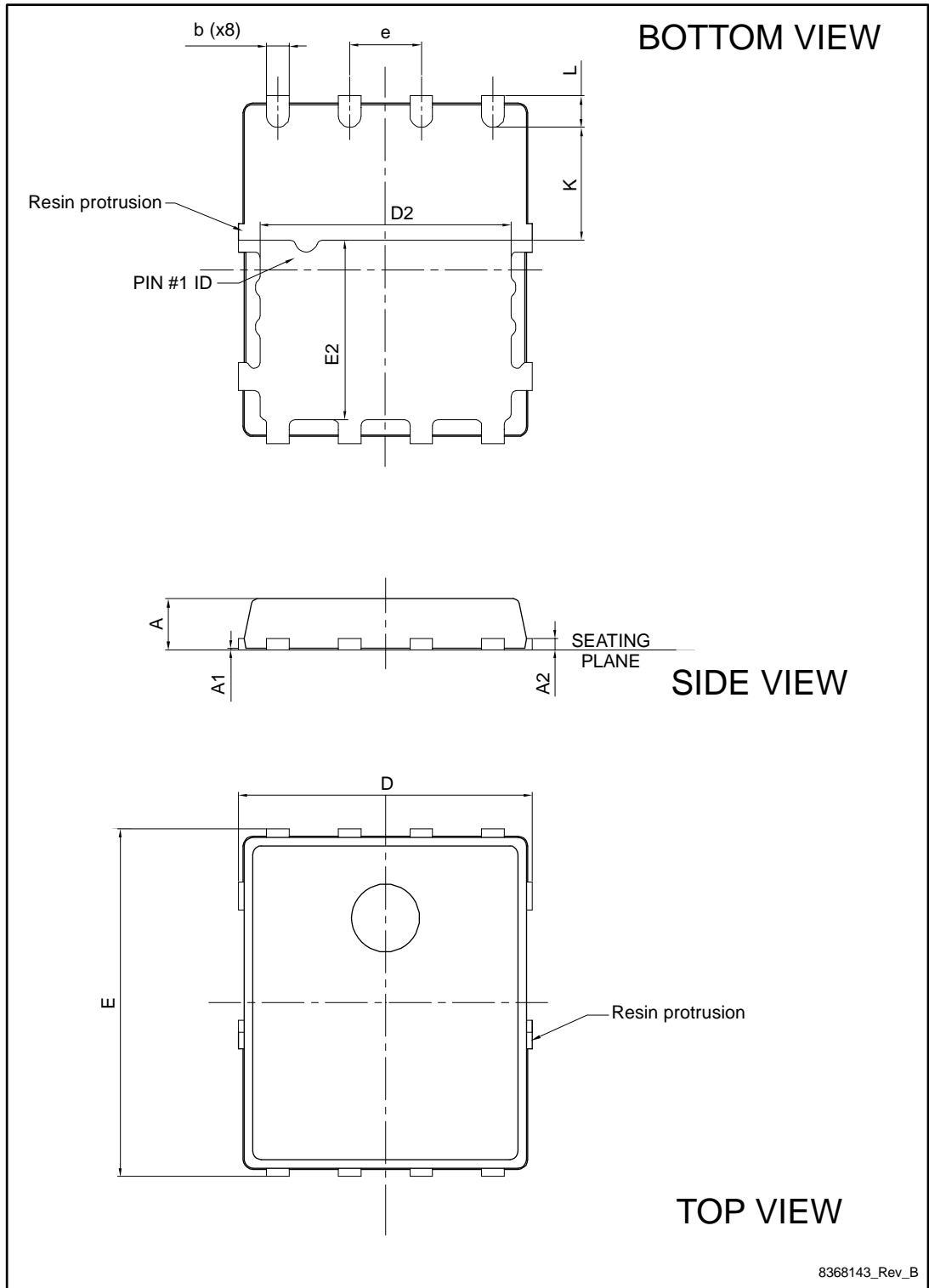
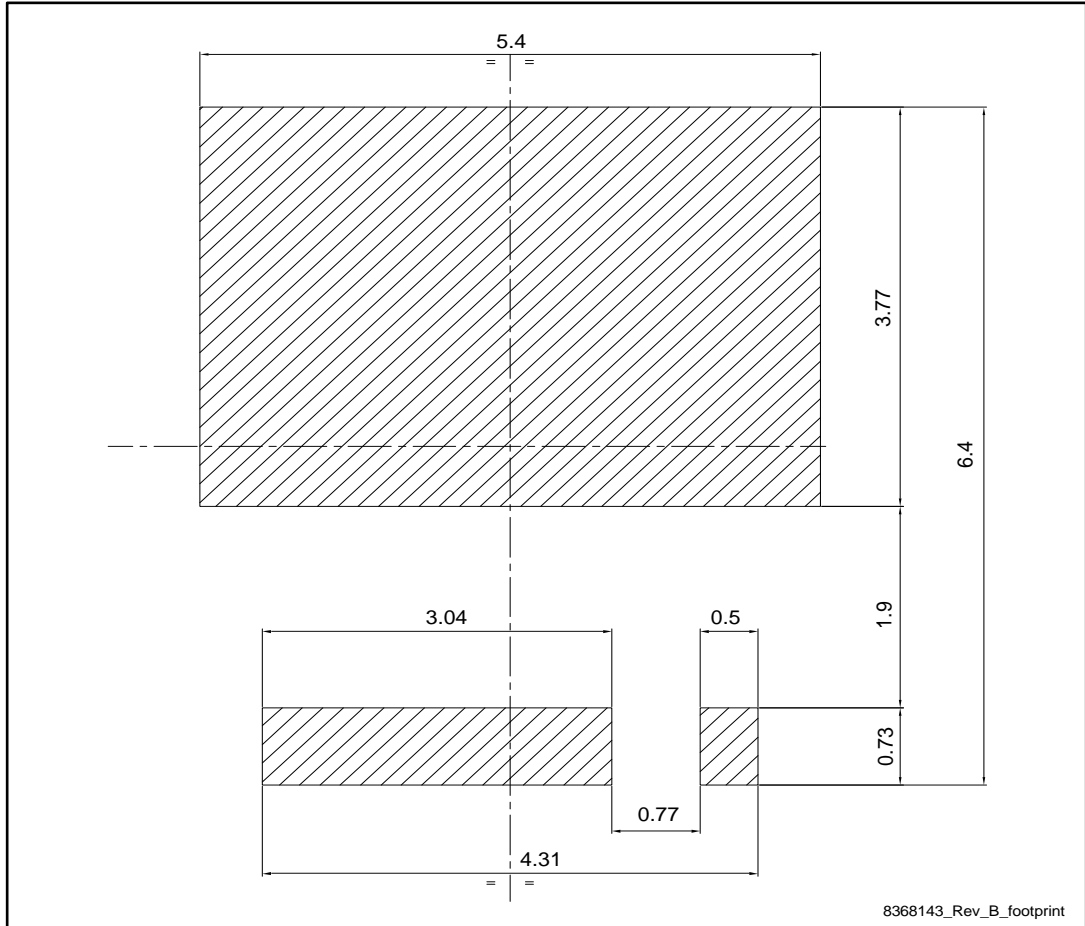


Table 10: PowerFLAT™ 5x6 HV mechanical data

| Dim. | mm   |      |      |
|------|------|------|------|
|      | Min. | Typ. | Max. |
| A    | 0.80 |      | 1.00 |
| A1   | 0.02 |      | 0.05 |
| A2   |      | 0.25 |      |
| b    | 0.30 |      | 0.50 |
| D    | 5.00 | 5.20 | 5.40 |
| E    | 5.95 | 6.15 | 6.35 |
| D2   | 4.30 | 4.40 | 4.50 |
| E2   | 3.10 | 3.20 | 3.30 |
| e    |      | 1.27 |      |
| L    | 0.50 | 0.55 | 0.60 |
| K    | 1.90 | 2.00 | 2.10 |

Figure 21: PowerFLAT™ 5x6 HV recommended footprint (dimensions are in mm)



## 4.2 Packing information

Figure 22: PowerFLAT™ 5x6 tape (dimensions are in mm)

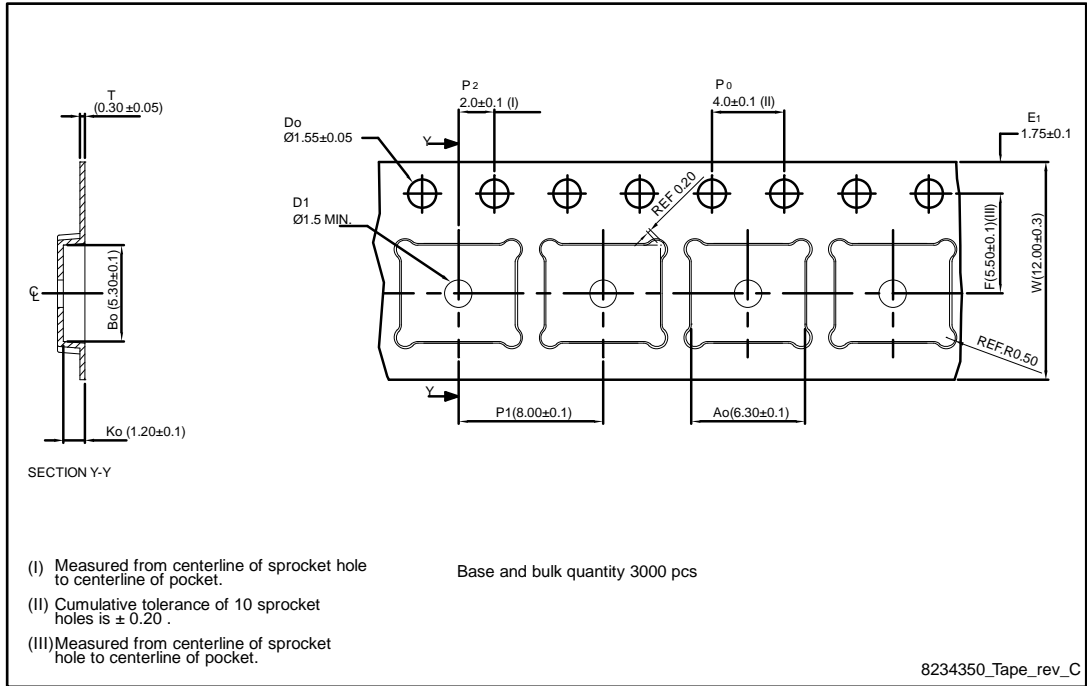


Figure 23: PowerFLAT™ 5x6 package orientation in carrier tape

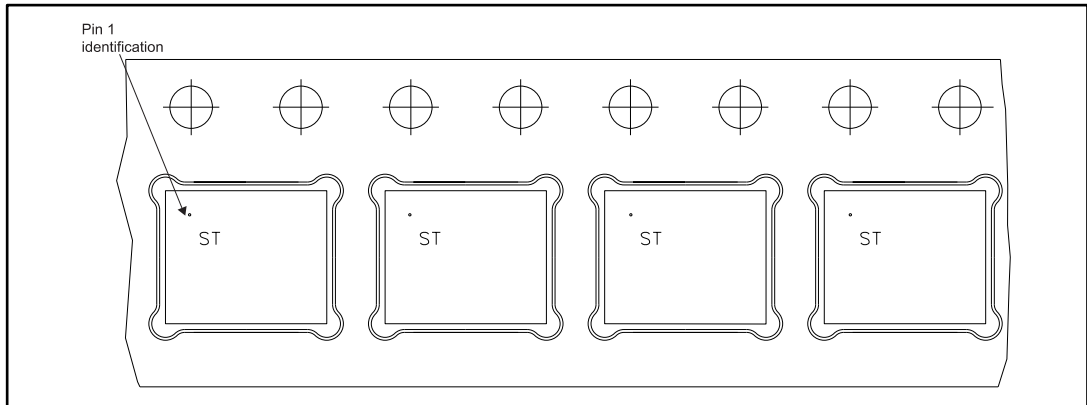
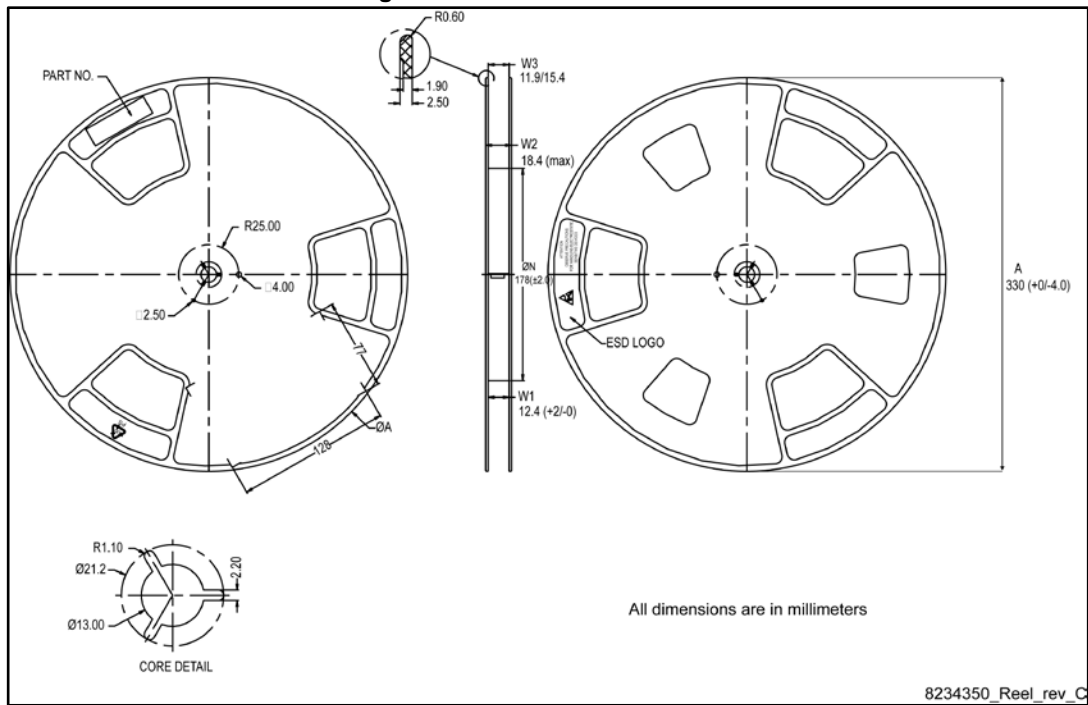


Figure 24: PowerFLAT™ 5x6 reel



## 5 Revision history

Table 11: Document revision history

| Date        | Revision | Changes        |
|-------------|----------|----------------|
| 18-May-2015 | 1        | First release. |

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